Application/Control No. Applicant(s)/Patent Under Reexamination JUMPPANEN ET AL. Examiner David M Brunsman Applicant(s)/Patent Under Reexamination JUMPPANEN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,663,717	12-2003	Antila et al.	127/34
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NON-PATENT DOCUMENTS

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